Power MOSFET 30 V, 46 A, Single N-Channel, SO-8 FL

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- CPU Power Delivery
- DC-DC Converters

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

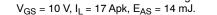
			1	<i>.</i>	
Parameter			Symbol	Value	Unit
Drain-to-Source Volt	age		V _{DSS}	30	V
Gate-to-Source Volta	age		V _{GS}	±20	V
Continuous Drain Current R _{0JA}		T _A = 25°C	Ι _D	15.0	A
(Note 1)		$T_A = 80^{\circ}C$		11.2	
Power Dissipation $R_{\theta JA}$ (Note 1)		T _A = 25°C	P _D	2.49	W
Continuous Drain		T _A = 25°C	I _D	22.5	А
Current $R_{\theta JA} \le 10 \text{ s}$ (Note 1)		T _A = 80°C		16.8	
Power Dissipation $R_{\theta JA} \leq 10 \text{ s} \text{ (Note 1)}$	Steady	T _A = 25°C	P _D	5.6	W
Continuous Drain	State	$T_A = 25^{\circ}C$	۱ _D	8.2	А
Current R _{θJA} (Note 2)		$T_A = 80^{\circ}C$		6.2	
Power Dissipation $R_{\theta JA}$ (Note 2)		T _A = 25°C	PD	0.75	W
Continuous Drain		T _C = 25°C	I _D	46	Α
Current R _{θJC} (Note 1)		T _C =80°C		34	
Power Dissipation $R_{\theta JC}$ (Note 1)		T _C = 25°C	PD	23.6	W
Pulsed Drain Current	T _A = 25°	² C, t _p = 10 μs	I _{DM}	132	A
Current Limited by Pa	ackage	$T_A = 25^{\circ}C$	I _{Dmax}	80	Α
Operating Junction an Temperature	nd Storage	•	T _J , T _{STG}	–55 to +150	°C
Source Current (Body	/ Diode)		۱ _S	21	Α
Drain to Source dV/d	t		dV/d _t	7.0	V/ns
Single Pulse Drain-to Energy ($T_J = 25^{\circ}C$, V L = 0.1 mH, R _{GS} = 25	_{GS} = 10 V,	I _L = 25 A _{pk} ,	E _{AS}	31	mJ
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.

2. Surface-mounted on FR4 board using the minimum recommended pad size.

3. This is the absolute maximum rating. Parts are 100% tested at $T_J = 25^{\circ}C$,

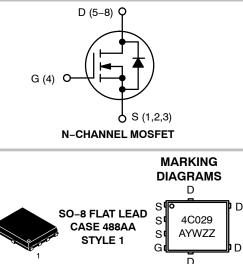


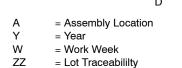


ON Semiconductor®

www.onsemi.com

V _{(BR)DSS}	R _{DS(ON)} MAX	I _D MAX
30 V	5.88 m Ω @ 10 V	46 A
30 V	9.0 mΩ @ 4.5 V	40 A





ORDERING INFORMATION

Device	Package	Shipping [†]
NTMFS4C810NT1G	SO-8 FL (Pb-Free)	1500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ ext{ heta}JC}$	5.3	
Junction-to-Ambient - Steady State (Note 4)	R_{\thetaJA}	50.3	°C/W
Junction-to-Ambient - Steady State (Note 5)	R_{\thetaJA}	165.9	°C/W
Junction-to-Ambient – (t \leq 10 s) (Note 4)	R_{\thetaJA}	22.2	

Surface-mounted on FR4 board using 1 sq-in pad, 1 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condi	tion	Min	Тур	Max	Unit	
OFF CHARACTERISTICS								
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V_{GS} = 0 V, I_D = 250 μ A		30			V	
Drain-to-Source Breakdown Voltage (transient)	V _{(BR)DSSt}	V_{GS} = 0 V, $I_{D(aval)}$ = 7.1 A, T_{case} = 25°C, $t_{transient}$ = 100 ns		34			V	
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} / T _J				14.5		mV/°C	
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 V,$ $T_{J} = 25^{\circ}C$				1.0	<u> </u>	
		V _{DS} = 24 V	$T_J = 125^{\circ}C$			10	μΑ	
Gate-to-Source Leakage Current	I _{GSS}	V_{DS} = 0 V, V_{GS}	= ±20 V			±100	nA	
ON CHARACTERISTICS (Note 6)								
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} = V _{DS} , I _D =	= 250 μA	1.3		2.2	V	
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				4.7		mV/°C	
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 30 A		4.9	5.88		
		V _{GS} = 4.5 V	I _D = 15 A		7.41	9.0	mΩ	
Forward Transconductance	9fs	V _{DS} = 1.5 V, I _D) = 15 A		43		S	
Gate Resistance	R _G	T _A = 25°C		0.3	1.0	2.0	Ω	
CHARGES AND CAPACITANCES								
Input Capacitance	C _{ISS}				987		pF	
Output Capacitance	C _{OSS}	V _{GS} = 0 V, f = 1 MHz	z, V _{DS} = 15 V		574			
Reverse Transfer Capacitance	C _{RSS}				162			
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15	V, f = 1 MHz		0.165			
Total Gate Charge	Q _{G(TOT)}				9.7			
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V, V _{DS} = 15 V; I _D = 30 A			1.5			
Gate-to-Source Charge	Q _{GS}				2.8		nC	
Gate-to-Drain Charge	Q _{GD}				4.8		1	
Gate Plateau Voltage	V _{GP}				3.2		V	
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 1	5 V; I _D = 30 A		18.6		nC	
SWITCHING CHARACTERISTICS (Note 7)	•			-	•	•	•	
Turn–On Delay Time	t _{d(ON)}				9.0			

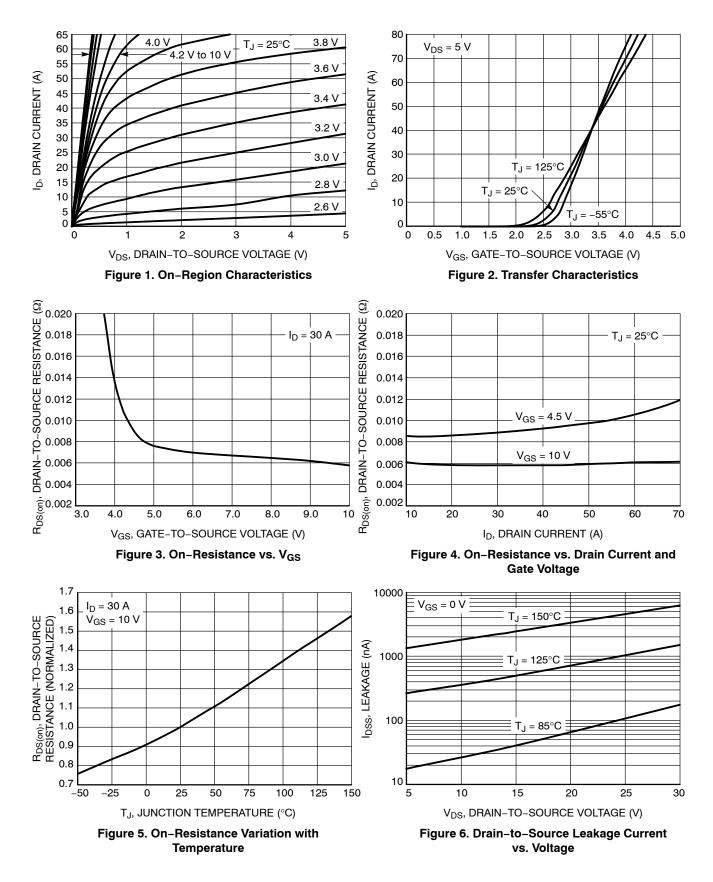
Turn-On Delay Time	t _{d(ON)}		9.0		
Rise Time	t _r	V _{GS} = 4.5 V, V _{DS} = 15 V,	34	20	
Turn–Off Delay Time	t _{d(OFF)}	I_D = 15 A, R_G = 3.0 Ω	14	ns	
Fall Time	t _f		7.0		

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

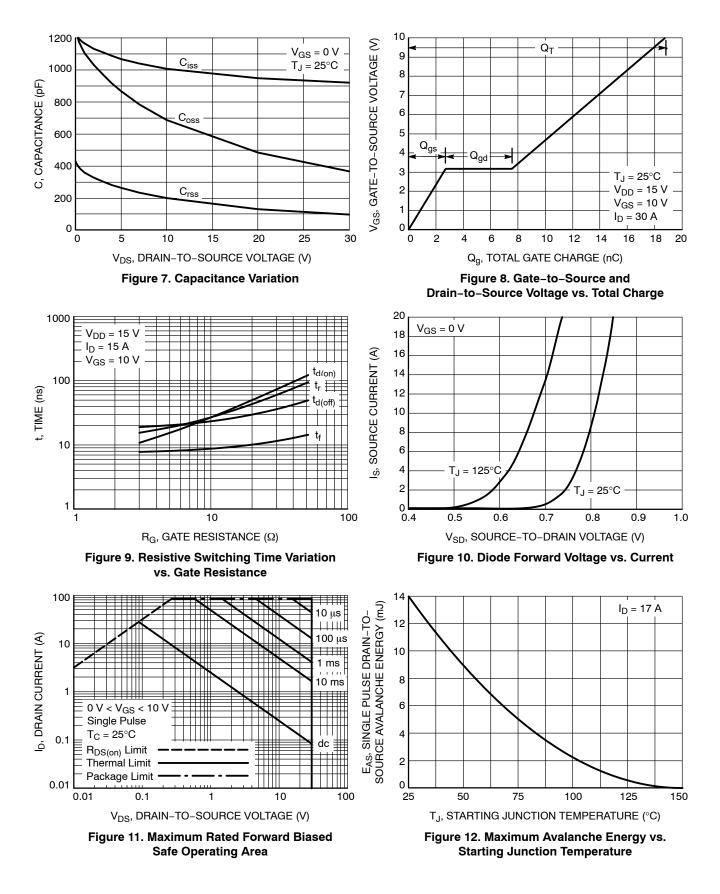
Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
SWITCHING CHARACTERISTICS (No	ote 7)				-	-	
Turn-On Delay Time	t _{d(ON)}				7.0		
Rise Time	t _r	V _{GS} = 10 V, V _C	V _{GS} = 10 V. V _{DS} = 15 V.		26		ns
Turn-Off Delay Time	t _{d(OFF)}	V_{GS} = 10 V, V _{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω			18		
Fall Time	t _f				4.0		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						
Forward Diode Voltage	V _{SD}	$V_{GS} = 0 V$, $T_J = 25^{\circ}C$			0.80	1.1	
		$I_{\rm S} = 10 \rm A$	T _J = 125°C		0.67		V
Reverse Recovery Time	t _{RR}	V _{GS} = 0 V, dI _S /dt = 100 A/μs, I _S = 30 A			26.7		
Charge Time	t _a				14.1		ns
Discharge Time	t _b				12.6		
Reverse Recovery Charge	Q _{RR}				13.7		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 6. Pulse Test: pulse width $\leq 300 \ \mu$ s, duty cycle $\leq 2\%$. 7. Switching characteristics are independent of operating junction temperatures.

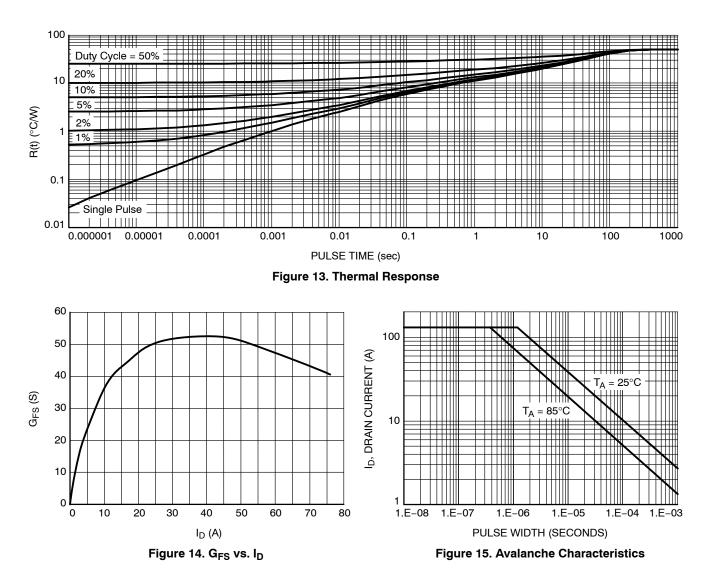
TYPICAL CHARACTERISTICS



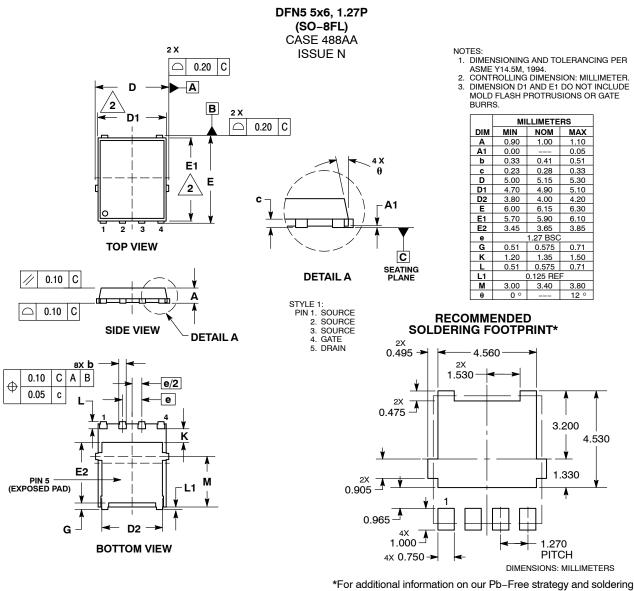
TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



PACKAGE DIMENSIONS



details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor roducts, "holding" parameters witch may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights or the rights of others. ON Semiconductor and the support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor for subtroired applications harmlese against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized application is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Middle East and Africa Technical Support:

Phone: 421 33 790 2910

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative